

**Search Notes**

Application/Control No.

10/511,972

Examiner

David J. Makiya

Applicant(s)/Patent under  
Reexamination

HOELEN ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	610,615	4/10/2006	DJM
	616,626		
	619,625		
	628		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Keyword Search in EAST attached	4/10/2006	DJM